

P-Channel MOSFET MEM2301X

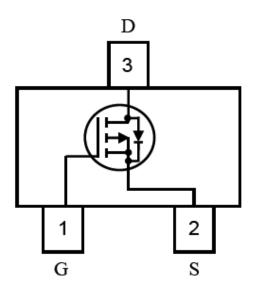
General Description

MEM2301XG Series P-channel enhancement mode field-effect transistor ,produced with high cell density DMOS trench technology, which is especially used to minimize on-state resistance. This device particularly suits low voltage applications, and low power dissipation, and low power dissipation in a very small outline surface mount package.

Features

- -20V/-2.8A
 - $R_{DS(ON)} = 93m\Omega@V_{GS} = -4.5V, I_D = -2.8A$
 - $R_{DS(ON)} = 113m\Omega@V_{GS} = -2.5V, I_D = -2A$
- High Density Cell Design For Ultra Low On-Resistance
- Subminiature surface mount package:SOT23

Pin Configuration



Typical Application

- Power management
- Load switch
- Battery protection

Absolute Maximum Ratings

Parai	Symbol	Ratings	Unit	
Drain-Source Voltage		V_{DSS}	-20	V
Gate-Source Voltage		V_{GSS}	±8	V
Continuous Drain Current	T _A =25℃		-2.8	А
	T _A =70°C	- I _D	-1.8	
Pulsed Drain Current ^{1,2}		I _{DM}	-10	А
Total Power Dissipation	T _A =25℃	В	0.7	W
	T _A =70°C	P _D	0.45	VV
Operating Temperature Range		T_{Opr}	150	$^{\circ}$
Storage Temperature Range		T _{stg}	-65/150	$^{\circ}$



Thermal Characteristics

Parameter	Symbol	MAX.	Unit
Thermal Resistance, Junction-to-Ambient ³	$R_{ hetaJA}$	145	°C/W

Electrical Characteristics

Parameter	Symbol	Test Condition	Min	Туре	Max	Unit			
Static Characteristics									
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_{D}=-250\mu A$	-20	-23		V			
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = -250 \mu A$	-0.4	0.58	-1	V			
Gate-Body Leakage	I _{GSS}	$V_{DS}=0V$, $V_{GS}=8V$		0.2	100	nA			
		V _{DS} =0V, V _{GS} =-8V		-0.2	-100	nA			
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-16V V _{GS} =0V		-1.5	-100	nA			
Static Drain-Source On-Resistance	R _{DS(ON)1}	V _{GS} =-4.5V,I _D =-2.8A		93	110	mΩ			
	R _{DS(ON)2}	V _{GS} =-2.5V,I _D =-2A		113	140	mΩ			
Forward Transconductance	g FS	$V_{DS} = -5 \text{ V}, I_{D} = -2.8 \text{ A}$		6.5		S			
Source-drain (diode forward) voltage	V_{SD}	V _{GS} =0V,I _S =-1A			-1.2	V			
	Dy	namic Characteristics							
Input Capacitance	Ciss	$V_{DS} = -6V$,		500		pF			
Output Capacitance	Coss	$V_{GS} = 0 V$,		115					
Reverse Transfer Capacitance	Crss	f = 1 MHz		60					
	Sw	itching Characteristics							
Turn-On Delay Time	td(on)	$V_{DD} = -6 \text{ V},$		5	25	ns			
Rise Time	tr	I _D =-1 A,		30	60				
Turn-Off Delay Time	td(off)	$V_{GEN} = -4.5 V$,		25	60				
Fall-Time	tf	Rg = 6 Ω		10	60				
Total Gate Charge	Qg	$V_{DS} = -6 V$,		4.0	10	nc			
Gate-Source Charge	Qgs	$V_{GS} = -4.5 \text{ V},$		0.8					
Gate-Drain Charge	Qgd	$I_D = -2.8A$		0.8					

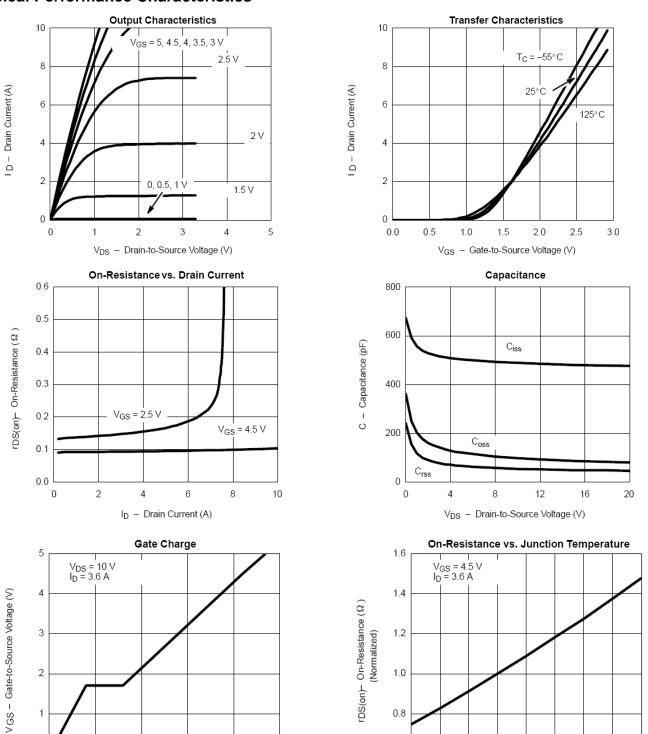
- 1. Pulse width limited by maximum junction temperature.
- 2. Pulse test: PW \leq 300 us duty cycle \leq 2%.
- 3. Surface Mounted on FR4 Board, t $\, \leqslant \, 5$ sec.



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Typical Performance Characteristics



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Q_g - Total Gate Charge (nC)

0.6

-50

-25

0

25

50

T_J – Junction Temperature (°C)

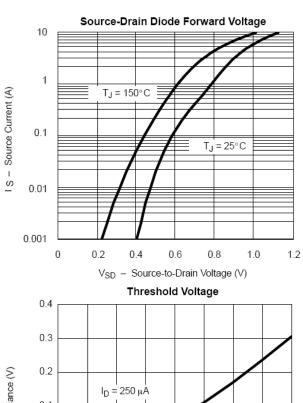
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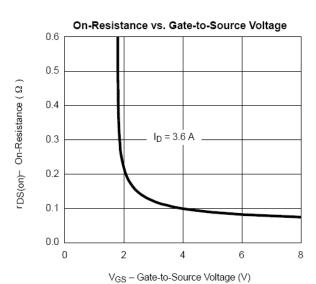
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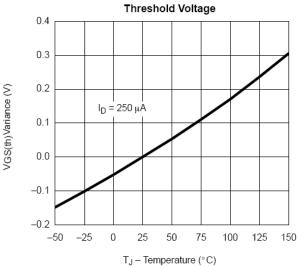
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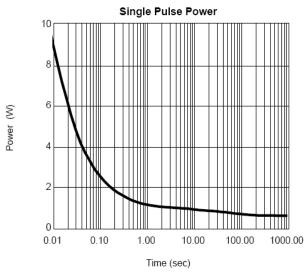
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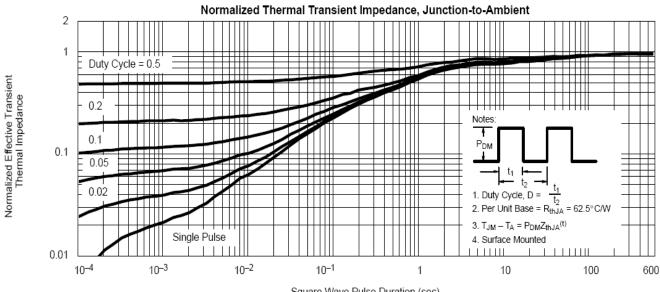








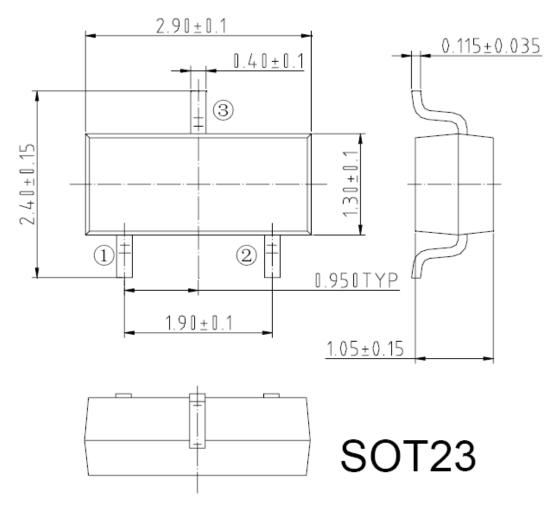




Square Wave Pulse Duration (sec)



Package Information





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